





参考資料

THVD8000

JAJSJ05A - MAY 2020 - REVISED MARCH 2021

THVD8000 OOK 変調付き RS-485 電力線通信用トランシーバ

1 特長

- 3V~5.5V の電源電圧
- 半二重通信
 - 最大 500kbps のデータ・レート (f₀ / bps = 10)
 - f₀ / bps < 10 の場合、より高いデータ・レートも可能
- オン / オフ・キーイング (OOK) 変調による RS-485 電 気信号伝達
- ピンで選択可能なキャリア周波数:125kHz~5MHz
- 拡散スペクトラム・クロック処理による優れた EMI 性能
- 無極性
- スタック・バス条件を回避するための **TX** タイムアウト
- 動作同相範囲:-7V~12V
- バス I/O 保護
 - ±18V の DC フォルト保護
 - ±16kV HBM ESD
 - ±8kV IEC 61000-4-2 接触放電
 - ±15kV IEC 61000-4-2 エアギャップ 放電
 - ±4kV IEC 61000-4-4 高速過渡バースト
- 拡張温度範囲:-40℃~125℃
- スペースに制約のあるアプリケーションに適した8ピン SOT-23 パッケージ

2 アプリケーション

- HVAC システム
- ビル・オートメーション
- ファクトリ・オートメーション / 制御
- 家電製品
- ライティング
- グリッド・インフラストラクチャ
- **PD** (パワー・デリバリー)

3 概要

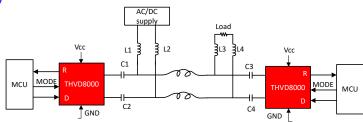
THVD8000 は、オン / オフ・キーイング (OOK) 変調およ び復調機能を備えた RS-485 電力線通信用トランシーバ です。既存の電力線上でデータを変調することで、電力伝 送とデータ通信が共通の 1 対の配線を共有できるため、 システム・コストを大幅に低減できます。

ピンで設定可能なインターフェイスを採用しているため、シ ステム設計が簡単です。キャリア周波数は、F_SET ピンの 外付け抵抗を変更することで調整できます。キャリア周波 数の可変範囲が広いため、システム設計者は外付けのイ ンダクタとコンデンサを柔軟に選択できます。また、OOK 変調はデータの極性に影響されないで動作するため、シ ステムの設置が簡単です。

製品情報

部品番号	パッケージ ⁽¹⁾	本体サイズ (公称)
THVD8000	SOT-23 (8)	2.90mm × 1.60mm

利用可能なすべてのパッケージについては、このデータシートの 末尾にある注文情報を参照してください。



概略回路図



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4 Revision History

資料番号末尾の英字は改訂を表しています。その改訂履歴は英語版に準じています。

Changes from Revision * (May 2020) to Revision A (March 2021)

Page



5 Pin Configuration and Functions

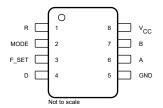


図 5-1. DRL Package, 8-Pin SOT-23, Top View

表 5-1. Pin Functions

ı	PIN	I/O	DESCRIPTION
NAME	NO.	_ 1/0	DESCRIPTION
R	1	Digital output	Receive data output
MODE	2	Digital input	Transmit/receive mode selection. Low = receive mode; High = transmit mode. 2-M Ω pull-down to GND
F_SET	3	Analog input	Carrier frequency selection. Use a resistor to GND to select a frequency.
D	4	Digital input	Driver data input, 2-M Ω pull-up to V $_{CC}$
GND	5	Ground	Device ground
Α	6	Bus input/output	Bus I/O port A (complementary to B)
В	7	Bus input/output	Bus I/O port B (complementary to A)
V _{CC}	8	Power	3.3-V to 5-V device supply



6 Specifications

6.1 Absolute Maximum Ratings

See (1)

		MIN	MAX	UNIT
V _{CC}	Supply voltage	-0.5	7	V
V _L	Input voltage at any logic pin (D, MODE or F_SET)	-0.3	5.7	V
V _A , V _B	Voltage at A or B inputs (differential or with respect to GND)	-18	18	V
Io	Receiver output current	-24	24	mA
TJ	Junction temperature		170	°C
T _{STG}	Storage temperature	-65	150	°C

⁽¹⁾ Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under セクション 6.4 is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

6.2 ESD Ratings

				VALUE	UNIT
		Human body model (HBM), per ANSI/ESDA/JEDEC JS-001 ⁽¹⁾	A and B pins to GND	±16,000	
V _(ESD)	Electrostatic discharge	Truman body model (Fibin), per ANGI/EGDA/JEDEC 33-00107	All pins	3 pins to GND ±16,000 ±4,000	_v
(ESD)		Charged-device model (CDM), per JEDEC specification JESD22-C101 ⁽²⁾	All pins		-

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
- (2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

6.3 ESD Ratings - IEC Specifications

			VALUE	UNIT
	IEC 61000-4-2 ESD contact discharge, A and B pins to GND	±8,000		
V _(ESD)	Electrostatic discharge	IEC 61000-4-2 ESD air gap discharge, A and B pins to GND	±15,000	V
		IEC 61000-4-4 electrical fast transient, A and B pins to GND	±4,000	

6.4 Recommended Operating Conditions

				MIN	NOM MAX	UNIT
V _{CC}	Supply voltage			3	5.5	V
V _{ID}	Input differential voltage (A and B pir	ns)		-7	12	V
V _{CM}	Operational common mode voltage (A and B pins)		-7	12	V
V _{IH}	High-level input voltage (D and MOD			2	V _{CC}	V
V _{IL}	Low-level input voltage (D and MOD	E pins)		0	0.8	V
	Output ourrent	Driver		-60	60	A
IO	Output current	Receiver		-4	4	mA
R _{F_SET}	Carrier frequency selection resistor			1.5	80	kΩ
ΔR_{F_SET}	Carrier frequency selection resistor t	olerance		-2	2	%
1/t _{UI}	Data rate	Modulation mode ⁽¹⁾			f ₀ / 10	bps
C _{F_SET}	Recommended load capacitance on	F_SET pin			100	pF
T _A	Operating ambient temperature			-40	125	°C

Product Folder Links: THVD8000

(1) f₀ is the carrier frequency (in Hz) set by the external resistor between F_SET and GND pins.

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6.5 Thermal Information

		THVD8000	
	THERMAL METRIC ⁽¹⁾		UNIT
		8 PINS	
R _{θJA}	Junction-to-ambient thermal resistance	106.6	°C/W
R ₀ JC(top)	Junction-to-case (top) thermal resistance	38.4	°C/W
R _{0JB}	Junction-to-board thermal resistance	29.9	°C/W
Ψлт	Junction-to-top characterization parameter	29.5	°C/W
ΨЈВ	Junction-to-top characterization parameter	29.5	°C/W

⁽¹⁾ For more information about traditional and new thermalmetrics, see the Semiconductor and ICPackage Thermal Metrics application report.

6.6 Electrical Characteristics

Over operating free-air temperature range (unless otherwise noted). All typical values are measured at 25° C and supply voltage of $V_{CC} = 5 \text{ V}$.

	PARAMETER	TEST CONDITION	NS	MIN	TYP	MAX	UNIT
Driver							
		R_L = 60 Ω, -7 V ≤ V_{test} ≤ 12 V, Measured at 2nd pulse	See 🗵 7-1	1.5	3.5		
V _{OD}	Driver differential output voltage magnitude	R_L = 100 Ω , C_L = 50 pF, Measured at 2nd pulse	See ⊠ 7-1	2	4		٧
		R_L = 54 Ω , C_L = 50 pF, Measured at 2nd pulse	See 🗵 7-1	1.5	3.5		
V _{OC}	Steady state common-mode output voltage	R _L = 60 Ω, C _L = 50 pF	See 図 7-2	1	V _{CC} / 2	3	V
ΔV _{OC}	Change in differential driver common-mode output voltage	R _L = 60 Ω, C _L = 50 pF	See 図 7-2	-160		160	mV
V _{OC(PP)}	Peak-to-peak driver common- mode output voltage	R_L = 60 Ω , C_L = 50 pF, V_{CC} = 3.3 V and V_{CC} = 5V	See 図 7-2		425		mV
Ios	Driver short-circuit output current	MODE = V_{CC} , $-7 \text{ V} \leq [V_A \text{ or } V_B] \leq 1$			250	mA	
	Minimum carrier frequency ⁽¹⁾	R_{F_SET} = 77 k Ω	0 70		125		kHz
f ₀	Maximum carrier frequency ⁽¹⁾	R_{F_SET} = 1.5 k Ω	See 🗵 7-3		5	3 160	MHz
DCD _{f0}	Carrier frequency duty cycle distortion	Measured over the full range of f ₀	1	-2		2	%
Δf_0	Carrier frequency tolerance	Measured with a ±2% tolerant R _{F_S}	ET	-25		25	%
Δf_{SSC}	Variation of the carrier frequency for spread spectrum clocking	Measured across the full carrier free	quency range		±5		%
f _{SSC}	Spread spectrum clock rate	1			30		kHz



Over operating free-air temperature range (unless otherwise noted). All typical values are measured at 25°C and supply voltage of V_{CC} = 5 V.

	PARAMETER	TEST CONDITIO	NS	MIN	TYP	MAX	UNIT
Receiver			'				
	Bus input current in receive	MODE - OND \/ - 0\/ 5.5\/	V _I = 12 V		75	125	
l _l	mode	MODE = GND, $V_{CC} = 0 \text{ V or } 5.5 \text{ V}$	V _I = -7 V	-97	-70		μA
	OOK signal differential swing		125 kHz			225	
V _{MAG_ZERO}	(magnitude) to detect a zero at		1 MHz			150	mV
	the R output		5 MHz			115	
	OOK signal differential swing		125 kHz	20			
V _{MAG_ONE}	(magnitude) to detect a one at	MODE = GND, over full common mode range	1 MHz	10			mV
	the R output		5 MHz	10			
			125 kHz	40			
V _{MAG_HYS}	Receiver differential input voltage threshold hysteresis		1 MHz	20			mV
	,g,,		5 MHz	20			
Logic / Contr	ol Pins						
I _{IN}	Input current (D, MODE)	V _O = 0 V or V _{CC}		- 5		5	μA
I _{IN}	Input current (F_SET)	V _O = V _{CC}	$V_O = V_{CC}$			55	μA
	Output voltage (F_SET)	$I_O = 0 \text{ mA}$			1.4		V
v _O	Output voltage (F_3E1)	$1.5 \text{ k}\Omega \le R_{PD} \le 78 \text{ k}\Omega$			785		mV
V _{OH}	Receiver high-level output voltage	I _{OH} = -4 mA		V _{CC} - 0.4	V _{CC} - 0.2		V
V _{OL}	Receiver low-level output voltage	I _{OL} = 4 mA			0.2	0.4	V
I _{OZ}	Receiver high-impedance output current	V _O = 0 V or V _{CC} , MODE = 0		-1		1	μΑ
Device							
	Cumbin surrent (quiescert)	Transmit mode	D = V _{CC} , MODE = V _{CC} , resistor between F_SET and GND, no load		3.1	5	A
Icc	Supply current (quiescent)	Receive mode	D = V _{CC} , MODE = GND, resistor between F_SET and GND, no load		4	6	mA
T _{SD}	Thermal shutdown temperature			160	170	185	°C
T _{HYS}	Thermal shutdown hysteresis				11	15	°C

⁽¹⁾ See OOK modulation section for the complete carrier frequency range

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6.7 Power Dissipation Characteristics

Over operating free-air temperature range (unless otherwise noted). All typical values are measured at 25° C and supply voltage of $V_{CC} = 5 \text{ V}$.

PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT
DD.	Chip power dissipation	MODE = V_{CC} , R_L = 60 Ω , no C_L , see	f ₀ = 125 kHz, 12.5 kHz (25 kbps) clock pattern as data		60	80	mW
PD _{OOK}	Crip power dissipation	Figure 2	f ₀ = 5 MHz, 500 kHz (1Mbps) clock pattern as data		90	125	mW

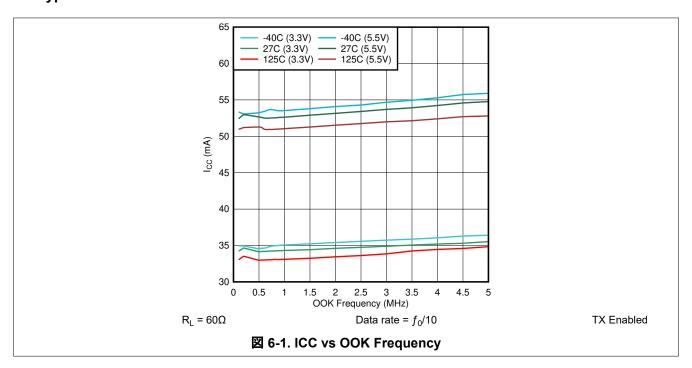
6.8 Switching Characteristics

Over operating free-air temperature range (unless otherwise noted). All typical values are measured at 25° C and supply voltage of $V_{CO} = 5$ V

	PARAMETER	AMETER TEST CONDITIONS		MIN	TYP	MAX	UNIT
Driver		•					
t _r , t _f	Driver differential output rise and fall times	3			10	30	ns
t _{PHL} , t _{PLH}	Driver propagation delay		R_L = 60 Ω, C_L = 50 pF, See \boxtimes 7-4		1.2	2.5	Clocks
t _{SK(P)}	Driver pulse skew, t _{PHL} - t _{PLH}				0.3	2.5	Clocks
Receiver						'	
t _r , t _f	Receiver output rise and fall times				1.5	16	ns
t _{PHL} , t _{PLH}	Receiver propagation delay time		C _L = 15 pF, See ⊠ 7-5		4	6.5	Clocks
t _{SK(P)}	Receiver pulse skew, t _{PHL} - t _{PLH}				1.1	3	CIOCKS
Device							
t _{TX-RX_OOK}	Transmit to receive mode change delay, OOK mode	For all R _{FSET}	Worst case of t_{TX} . RX_OOK_ZERO and t_{TX} . RX_OOK_ONE. See \boxtimes 7-6 and \boxtimes 7-7			14	clocks
t _{RX-TX_OOK}	Receive to transmit mode change delay, OOK mode	For all R _{FSET}	See ⊠ 7-8			12	clocks
t _{TX_TIMEOUT}	Transmit timeout delay	•		60	110		s



6.9 Typical Characteristics





7 Parameter Measurement Information

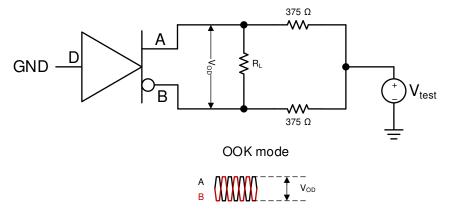


図 7-1. Measurement of Driver Differential Output Voltage With Common-Mode Load

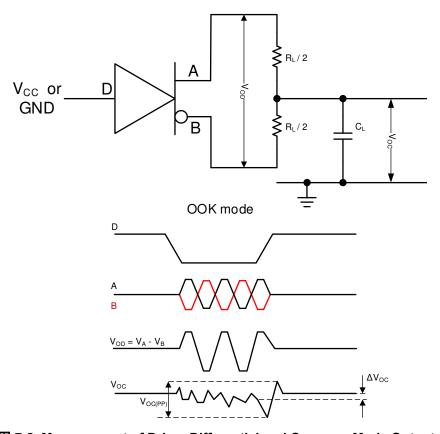


図 7-2. Measurement of Driver Differential and Common-Mode Outputs



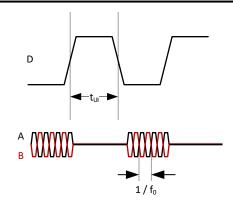


図 7-3. Measurement of Carrier Frequency

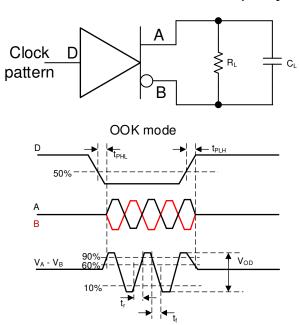
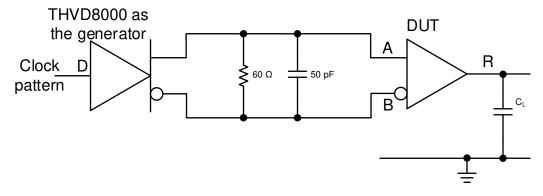


図 7-4. Measurement of Driver Switching Characteristics





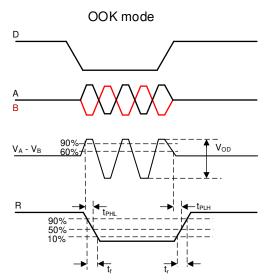
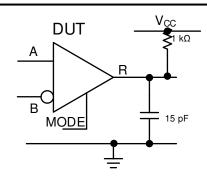


図 7-5. Measurement of Receiver Characteristics





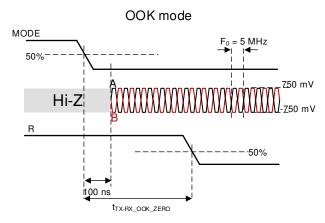
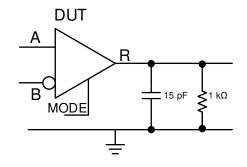


図 7-6. Transmit to Receive Mode Change with Low Output



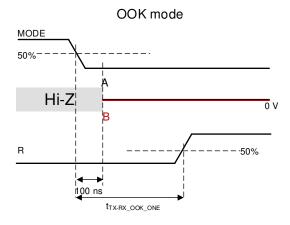


図 7-7. Transmit to Receive Mode Change with High Output

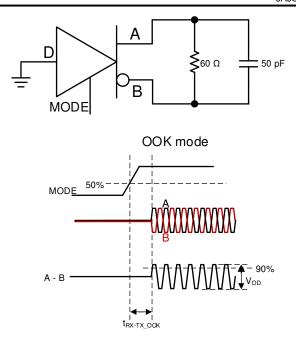


図 7-8. Receive to Transmit Mode Change

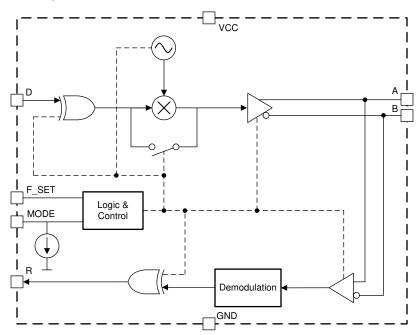


8 Detailed Description

8.1 Overview

THVD8000 enables power line communication using RS-485 physical layer signaling. An integrated OOK modulator enables RS-485 data to be directly coupled onto existing power cables via series capacitors without any updates to the MCU or the controller. The THVD8000 receiver extracts the data from the power cables through series capacitors by using a precise bandpass filter and a demodulator.

8.2 Functional Block Diagrams



8.3 Feature Description

8.3.1 OOK Modulation with F SET pin

Data at the D input is modulated with the carrier frequency (f_0) via the F_SET pin. \boxtimes 8-1 illustrates the modulation scheme. A high level at the D input is driven to the mid-level with zero differential voltage (V_{OD}). A low level at the D input is modulated at the carrier frequency. It is recommended to use a carrier frequency that is 10x higher than the data rate. Higher data rates are possible at the expense of increased pulse width distortion with the use of lower ratios.

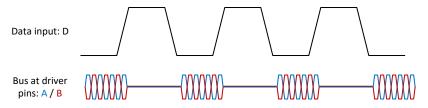


図 8-1. OOK Modulation Scheme

 f_0 is programmable by changing the external resistor (R_{F_SET}) value connected to ground. $\frac{1}{2}$ 8-1 shows the carrier frequency for the each recommended resistor value.

表 8-1. OOK f₀ versus R_{F_SET}

R_{F_SET} (k Ω)	OOK f ₀ (kHz)
77	125
50	187.5
19	500

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表 8-1. OOK f₀ versus R_{F_SET} (continued)

R _{F_SET} (kΩ)	OOK f ₀ (kHz)
12.5	750
9.3	1000
4.4	2000
1.5	5000

The oscillator used to generate the carrier frequency features spread spectrum clocking to reduce emissions.

8.3.2 OOK Demodulation

The OOK signal received at the A and B inputs go through a bandpass filter and a peak detector to regenerate the original data stream. \boxtimes 8-2 shows the OOK input and the R output waveforms. The bandpass filter characteristics will adapt to optimal settings automatically based on the carrier frequency, set via $R_{F \ SET}$.

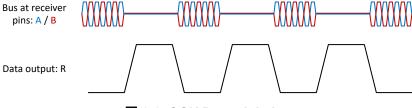


図 8-2. OOK Demodulation

8.3.3 Transmitter Timeout

The driver path incorporates a timeout feature to prevent a faulty node from occupying the bus indefinitely in a multi-drop application.

The driver stops transmitting and the outputs will go high impedance if the D input doesn't detect an edge (either rising or falling) for longer than $t_{TX_TIMEOUT}$. One of the following events brings the device back to normal operation.

- Any edge at D input
- · Toggle MODE pin

The transmit path resumes operation within t_{MODE}.

8.3.4 Polarity Free Operation

THVD8000 is immune to A and B polarity at the receiver input in OOK mode. The receiver data comparator only checks for the receive input signal magnitude, ignoring the polarity, to determine its logic level. Note that reversing the polarity does result in degraded pulse width distortion.

8.3.5 Glitch Free Mode Change

The device incorporates a delay of up to t_{MODE} when changing the state of the MODE pin. This feature ensures that there are no glitches at the A, B and R outputs when transitioning between transmit and receive modes.

8.3.6 Integrated IEC ESD and EFT Protection

Internal ESD protection circuits protect the transceiver against electrostatic discharges (ESD) according to IEC 61000-4-2 of up to ±8 kV contact and against electrical fast transients (EFT) according to IEC 61000-4-4 of up to ±4 kV. This integrated protection eliminates the need of external components reducing the system BOM.



8.4 Device Functional Modes

表 8-2. THVD8000 Functional Modes

F_SET Configuration	Device Functional Mode
R _{F_SET} between F_SET and GND	OOK mode, f_0 set by the R_{F_SET} value
F_SET at high impedance	
F_SET at V _{CC}	Invalid, not recommended for normal operation
F_SET short to GND	

8.4.1 OOK Mode

Data at the D input is modulated with the carrier frequency set by the R_{F_SET} value when the device is transmitting (MODE = V_{CC}). See $\forall \not \supset \not \supset \lor 1$ 8.3.1 section for more details. In receiving (MODE = GND), the device expects an OOK modulated signal at the A and B inputs. The data is demodulated and sent out via R pin. See $\forall \not \supset \lor 1$ 8.3.2 section for more details.

表 8-3. Driver function table for OOK mode

	INPUTS		OUT	FUNCTION	
F_SET	MODE	D	Α	В	
R _{F_SET} (See 表 8-1)	Н	H or Z	Bias to V _{CM}	Bias to V _{CM}	Driver is actively biased to V _{CM} on the bus
	Н	L	Oscillating	Oscillating	Bus actively driven at carrier frequency
	L or Z	X	Z	Z	Driver disabled, device in receive mode

表 8-4. Receiver function table for OOK mode

	INPUTS		OUTPUT	FUNCTION						
F_SET	MODE	Input	R							
R _{F_SET} (See 表 8-1)	L or Z	Oscillating at F_SET and V _{ID} > V _{MAG_ZERO}	L	Receive valid bus low						
	L or Z	Oscillating at F_SET and V _{MAG_ONE} < V _{ID} < V _{MAG_ZERO}	?	Receive invalid bus, output indeterminate						
	L or Z Oscillating at F_SET and V _{IE} V _{MAG_ONE}	Oscillating at F_SET and V _{ID} < V _{MAG_ONE}	Н	Receive valid bus high						
	L or Z	Z / not oscillating	Н	Receive valid bus high						
L or Z		OPEN, SHORT, IDLE (V _{ID} = 0 V)	Н	Failsafe high output						
	Н	Х	Z	Receiver disabled, device in transmit mode						

8.4.2 Thermal shutdown (TSD)

The THVD8000 has a protection feature called thermal shutdown. When the junction temperature reaches T_{SD} , the device enters thermal shutdown protection mode. This mode disables the driver and receiver outputs, which will halt all communication through the device. Normal operation resume once the junction temperature drops out of thermal shutdown, which is typically T_{SD} - T_{HYS} .

Product Folder Links: THVD8000

9 Application Information Disclaimer

Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

9.1 Application information

The THVD8000 is able to transmit data over an AC coupled power line pair using On-Off Keying (OOK).

9.2 Typical application (OOK mode)

In order to combine data and power over a single pair of wires, capacitors and inductors are used in a bias-tee configuration. High-frequency differential data is AC-coupled onto the bus lines via series capacitances while power is DC-coupled via series inductances. The values of these components will depend on the carrier frequency, number of nodes on the bus, and the power delivery requirements (i.e., voltage and total current sourced or consumed by a given node).

The transmitted differential communication signal is AC-coupled onto the power bus as shown below. This configuration provides the advantage that the power transmitted on the bus has little impact on the differential data, allowing for a wide range of voltage and current scenarios. Typical applications are realized with the THVD8000 transmitting over a power bus of 24VDC or 24VAC with currents from 100mA to 1A, but due to the AC-coupling the THVD8000 does not directly see these voltages. For more information, please refer for the THVD8000 design guide.

In 🗵 9-1, there is an optional rectifier network pictured on the bus lines. This network of diodes can ensure that the node is receives power correctly from the bus wires, even if the lines get swapped.

A termination resistance, R_T , is not required for device functionality but can be useful in improving signal integrity in some applications by reducing reflections that can occur at cable ends.

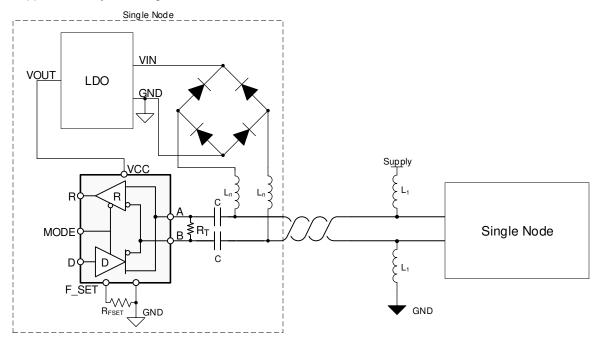


図 9-1. Typical power line network with 2 nodes

9.2.1 Design requirements

The main requirements are the values of the bus capacitors and the power inductors. Both of these values are dependant upon the carrier frequency selected.

9.2.1.1 Carrier frequency

This device uses on-off-keying to transmit binary data on the bus. Please read セクション 8.3.1 for detailed information. The modulation and demodulation of the data can result in pulse width distortion due to asymmetries in low-to-high and high-to-low transition times. These asymmetries are due to factors like synchronization of the data to the internal carrier oscillator in the transmit path and the response time of the band-pass filter in the receive path. The impact of these factors can be minimized by choosing a carrier frequency much higher than the data rate required. A frequency ratio of at least 10:1 is recommended.

9.2.2 Detailed design procedure

9.2.2.1 Inductor value selection

It is important to note that the inductor selected must also take power consumption into consideration. The inductor should be sized to handle the maximum anticipated current in addition to the inductance value.

The parallel aggregate impedance should be selected so that the total equivalent impedance at the carrier frequency is $Z \ge 375~\Omega$. This assumes RS-485 loading with 60 Ω termination. If no termination is used in the application, then the total equivalent impedance at the carrier frequency could be reduced to $Z \ge 60~\Omega$. These examples assume that termination is used. $\not \equiv 1$ shows the parallel aggregate impedance equation for inductors L_1 to L_n . Since the inductance value for each node should be the same, it's simple to determine that each node's impedance should be n times the total equivalent impedance. For example, if there are 4 nodes connected to the bus and the equivalent impedance is 375 Ω , then each node impedance should be 1,500 Ω .

$$Z = Z_1 ||Z_2|| ... ||Z_n$$
 (1)

To determine the suggested inductance value, $\not \equiv 2$ can be rearranged to determine L_n , as shown in $\not \equiv 3$.

$$Z_n = 2\pi f_0 L_n \tag{2}$$

$$L_n = \frac{Z_n}{2\pi f_0} \tag{3}$$

 f_0 is the carrier frequency (OOK frequency) used. If the previous 1.5 k Ω impedance per node is assumed with a carrier frequency of 1 MHz, the resulting inductance limit is ~240 μ H per node. Be aware that this is the minimum suggested value per node. Refer to \boxtimes 9-2 as a quick reference on the minimum inductance value to achieve 375 Ω of total aggregate impedance. This value can be multiplied by the number of nodes on the bus to get the minimum inductance per node. Referring to the previous example, if there are 4 nodes and a carrier frequency of 1 MHz, then the minimum aggregate inductance is about 60 μ H, which is 240 μ H when multiplied by 4.

9.2.2.2 Capacitor value selection

Capacitor selection is easier than inductor selection, primarily because capacitance impedance is important to allow higher frequency signals through. However, the capacitor ratings for voltage must be carefully selected to meet the application requirements. Special considerations for hot plug nodes should be made to ensure that voltage transients during hot plugging do not exceed the absolute maximum values. See セクション 6.1.

The number of nodes on the bus does not play into the capacitance calculation. The impedance of a capacitor is shown in ± 4 .

$$Z = \frac{1}{2\pi f_0 C} \tag{4}$$

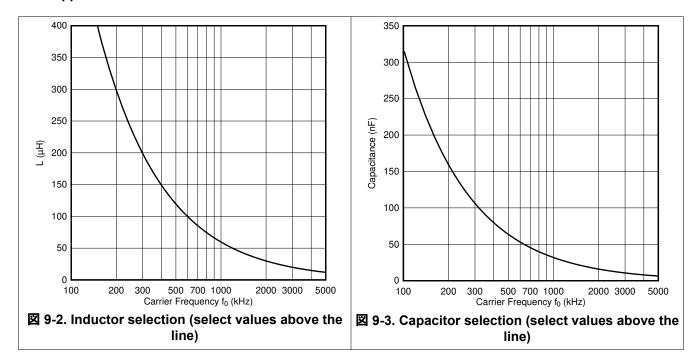


Maintaining $Z \le 5$ Ω keeps the impedance low enough at the carrier frequency to allow data to pass through. If the equation is rearranged to calculate C, the result is shown in ± 5 .

$$C = \frac{1}{2\pi f_0 Z} \tag{5}$$

If the previous example of a 1 MHz carrier frequency is used, then a minimum capacitance value of about 32 nF. For a quick reference, refer to \boxtimes 9-3.

9.2.3 Application Curves



10 Power supply recommendations

To ensure reliable operation at all data rates and supply voltages, the supply should be decoupled with a 100 nF to 220 nF ceramic capacitor and a 1 μ F capacitor (for ESD sensitive designs) located as close to the supply pins as possible. This helps to reduce supply voltage ripple present on the outputs of switched-mode power supplies and also helps to compensate for the resistance and inductance of the PCB power planes.



11 Layout

11.1 Layout guidelines

Robust and reliable bus node design often requires the use of external transient protection devices in order to protect against surge transients that may occur in industrial environments. Since these transients have a wide frequency bandwidth (from approximately 3 MHz to 300 MHz), high-frequency layout techniques should be applied during PCB design.

- 1. Place the protection circuitry close to the bus connector to prevent noise transients from propagating across the board.
- 2. Use V_{CC} and ground planes to provide low inductance. Note that high-frequency currents tend to follow the path of least impedance and not the path of least resistance.
- 3. Place F_SET components near the pin to keep capacitance load below recommended value
- 4. Use a pull up or down resistor on mode to set a default state
- 5. Apply 100-nF to 220-nF decoupling capacitors as close as possible to the V_{CC} pins of transceiver, UART and/or controller ICs on the board.
- 6. Use at least two vias for V_{CC} and ground connections of decoupling capacitors and protection devices to minimize effective via inductance.
- 7. Use 1-k Ω to 10-k Ω pull-up and pull-down resistors for enable lines to limit noise currents in theses lines during transient events.
- 8. Insert pulse-proof resistors into the A and B bus lines if the TVS clamping voltage is higher than the specified maximum voltage of the transceiver bus pins. These resistors limit the residual clamping current into the transceiver and prevent it from latching up.
- 9. While pure TVS protection is sufficient for surge transients up to 1 kV, higher transients require metal-oxide varistors (MOVs) which reduce the transients to a few hundred volts of clamping voltage, and transient blocking units (TBUs) that limit transient current to less than 1 mA.

11.2 Layout Example

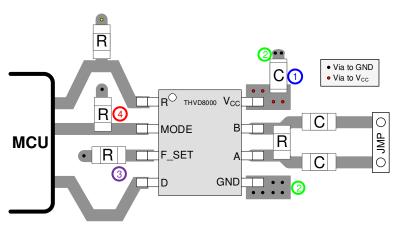


図 11-1. Layout Example (OOK)

12 Device and Documentation Support

12.1 Device Support

12.2 ドキュメントの更新通知を受け取る方法

ドキュメントの更新についての通知を受け取るには、ti.com のデバイス製品フォルダを開いてください。「更新の通知を受け取る」をクリックして登録すると、変更されたすべての製品情報に関するダイジェストを毎週受け取れます。変更の詳細については、修正されたドキュメントに含まれている改訂履歴をご覧ください。

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12.6 用語集

TI 用語集 この用語集には、用語や略語の一覧および定義が記載されています。

Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

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PACKAGING INFORMATION

Orderable part number	Status	Material type	Package Pins	Package qty Carrier	RoHS (3)	Lead finish/ Ball material	MSL rating/ Peak reflow	Op temp (°C)	Part marking (6)
						(4)	(5)		
THVD8000DDFR	Active	Production	SOT-23-THIN (DDF) 8	3000 LARGE T&R	Yes	SN	Level-1-260C-UNLIM	-40 to 125	8000
THVD8000DDFR.A	Active	Production	SOT-23-THIN (DDF) 8	3000 LARGE T&R	Yes	SN	Level-1-260C-UNLIM	-40 to 125	8000

⁽¹⁾ Status: For more details on status, see our product life cycle.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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⁽²⁾ Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

⁽³⁾ RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

⁽⁴⁾ Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

⁽⁵⁾ MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

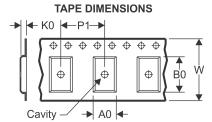
⁽⁶⁾ Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

PACKAGE MATERIALS INFORMATION

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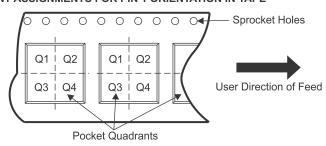
TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device		Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
THVD8000DDFR	SOT- 23-THIN	DDF	8	3000	180.0	9.5	3.17	3.1	1.1	4.0	8.0	Q3

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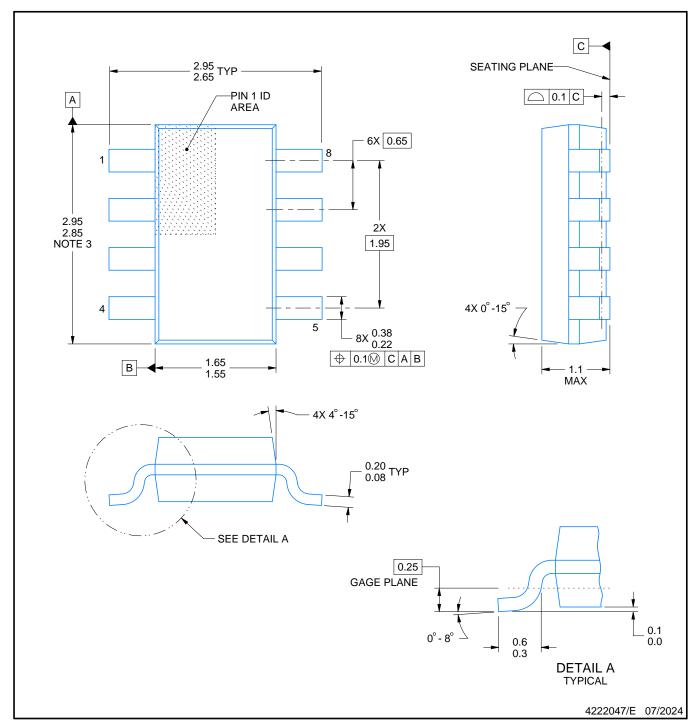


*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
THVD8000DDFR	SOT-23-THIN	DDF	8	3000	184.0	184.0	19.0



PLASTIC SMALL OUTLINE



NOTES:

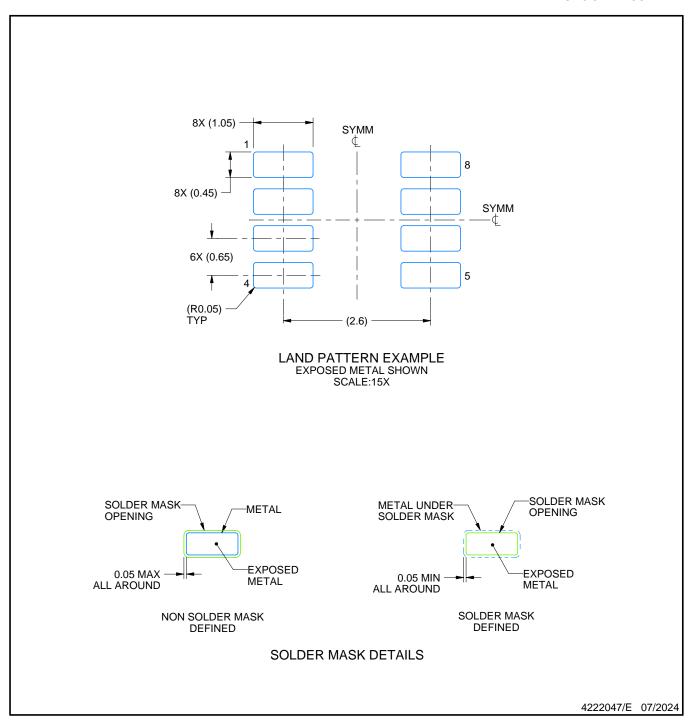
- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.



PLASTIC SMALL OUTLINE

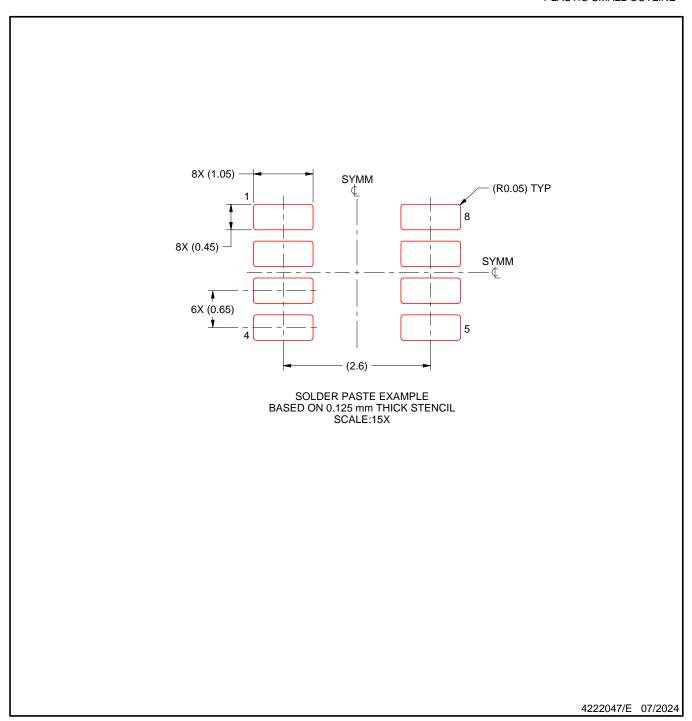


NOTES: (continued)

- 4. Publication IPC-7351 may have alternate designs.
- 5. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



PLASTIC SMALL OUTLINE



NOTES: (continued)

- 6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 7. Board assembly site may have different recommendations for stencil design.



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